

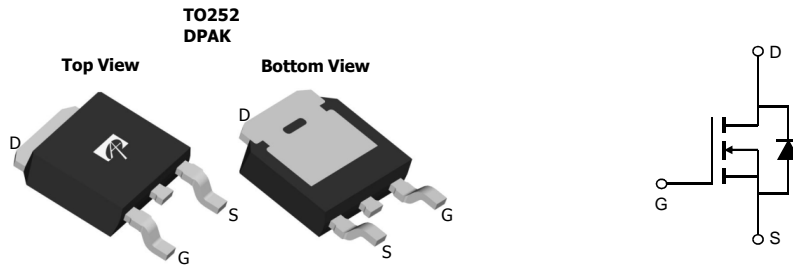
General Description

The AOD450 uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. This device is suitable for use in inverter, load switching and general purpose applications.

Product Summary

V_{DS}	200V
I_D (at $V_{GS}=10V$)	3.8A
$R_{DS(ON)}$ (at $V_{GS}=10V$)	< 0.70 Ω

100% UIS Tested
 100% R_g Tested



Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	V_{DS}	200	V
Gate-Source Voltage	V_{GS}	± 30	V
Continuous Drain Current	I_D	$T_C=25^\circ\text{C}$	3.8
		$T_C=100^\circ\text{C}$	2.7
Pulsed Drain Current ^C	I_{DM}	10	A
Avalanche Current ^C	I_{AS}	3	A
Avalanche energy $L=1.35\text{mH}$ ^C	E_{AS}	6	mJ
Power Dissipation ^B	P_D	$T_C=25^\circ\text{C}$	25
		$T_C=100^\circ\text{C}$	12.5
Power Dissipation ^A	P_{DSM}	$T_A=25^\circ\text{C}$	2.1
		$T_A=70^\circ\text{C}$	1.3
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 175	$^\circ\text{C}$

Thermal Characteristics

Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient ^A	$R_{\theta JA}$	17.1	30	$^\circ\text{C/W}$
Maximum Junction-to-Ambient ^{A,D}				
Maximum Junction-to-Ambient ^{A,D}	$R_{\theta JA}$	50	60	$^\circ\text{C/W}$
Maximum Junction-to-Case	$R_{\theta JC}$	4	6	$^\circ\text{C/W}$

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =10mA, V _{GS} =0V	200			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =160V, V _{GS} =0V T _J =55°C			1 5	μA
I _{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} =±30V			±100	nA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250μA	3	5	6	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =3.8A T _J =125°C		0.55 1.1	0.7 1.32	Ω
g _{FS}	Forward Transconductance	V _{DS} =15V, I _D =3.8A		8.7		S
V _{SD}	Diode Forward Voltage	I _S =1A, V _{GS} =0V		0.8	1	V
I _S	Maximum Body-Diode Continuous Current ^G				6	A
DYNAMIC PARAMETERS						
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =25V, f=1MHz	170	215	260	pF
C _{oss}	Output Capacitance		20	32	50	pF
C _{rss}	Reverse Transfer Capacitance		3	7.2	15	pF
R _g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz		5.5		Ω
SWITCHING PARAMETERS						
Q _{g(10V)}	Total Gate Charge	V _{GS} =10V, V _{DS} =25V, I _D =3.8A		3.82		nC
Q _{g(4.5V)}	Total Gate Charge		0.92		nC	
Q _{GS}	Gate Source Charge		1.42		nC	
Q _{gd}	Gate Drain Charge		1.47		nC	
t _{D(on)}	Turn-On DelayTime	V _{GS} =10V, V _{DS} =25V, R _L =6.5Ω, R _{GEN} =3Ω		6.3		ns
t _r	Turn-On Rise Time		3.3		ns	
t _{D(off)}	Turn-Off DelayTime		10.5		ns	
t _f	Turn-Off Fall Time		2.8		ns	
t _{rr}	Body Diode Reverse Recovery Time	I _F =3.8A, di/dt=100A/μs		59		ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =3.8A, di/dt=100A/μs		142		nC

A. The value of R_{θJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C. The Power dissipation P_{DSM} is based on R_{θJA} and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.

B. The power dissipation P_D is based on T_{J(MAX)}=175° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=175° C. Ratings are based on low frequency and duty cycles to keep initial T_J=25° C.

D. The R_{θJA} is the sum of the thermal impedance from junction to case R_{θJC} and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=175° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

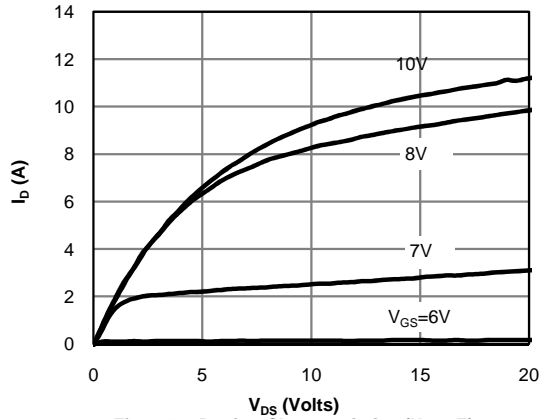


Fig 1: On-Region Characteristics (Note E)

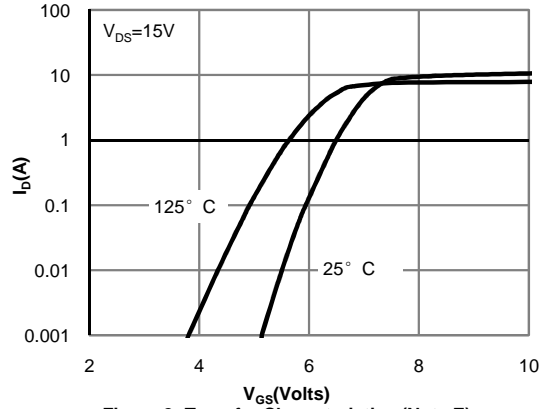


Figure 2: Transfer Characteristics (Note E)

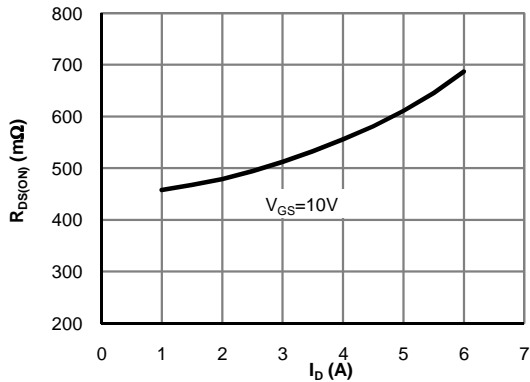


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

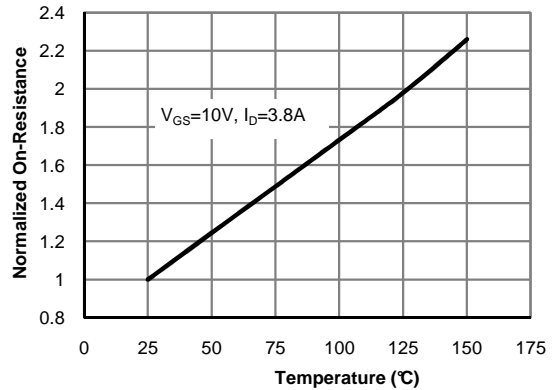


Figure 4: On-Resistance vs. Junction Temperature (Note E)

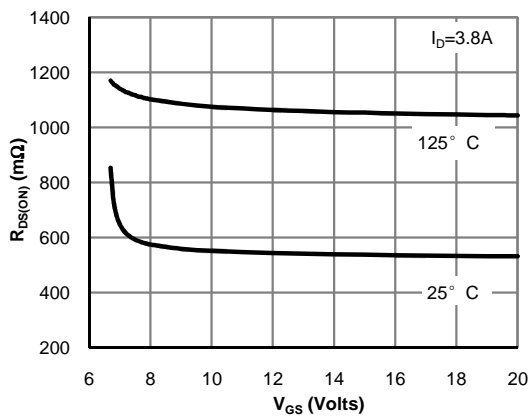


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

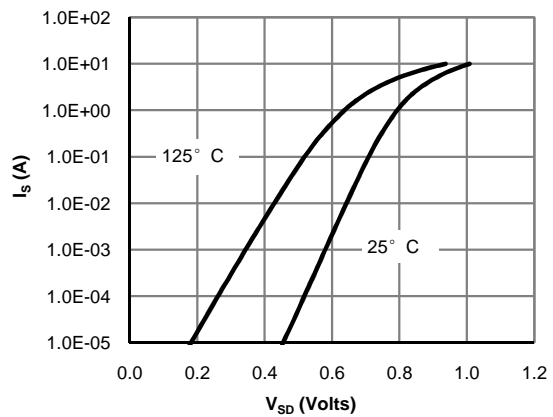


Figure 6: Body-Diode Characteristics (Note E)

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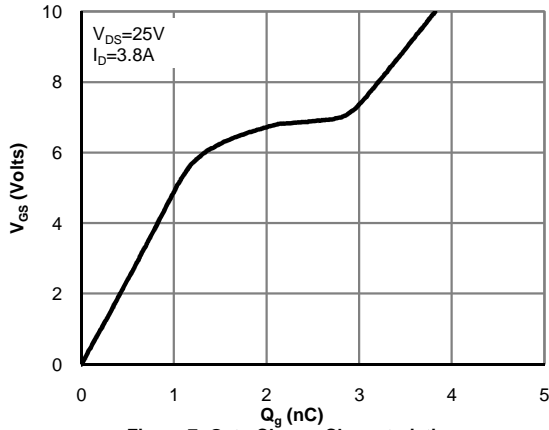


Figure 7: Gate-Charge Characteristics

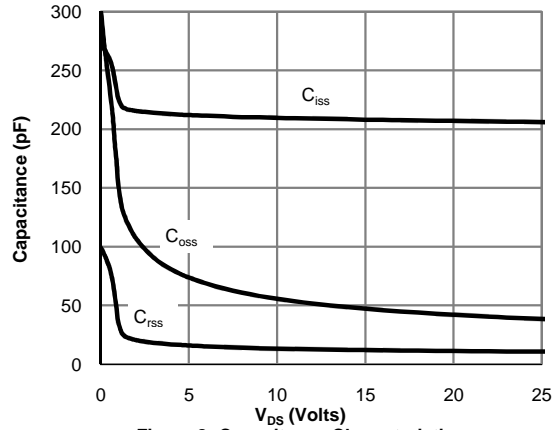


Figure 8: Capacitance Characteristics

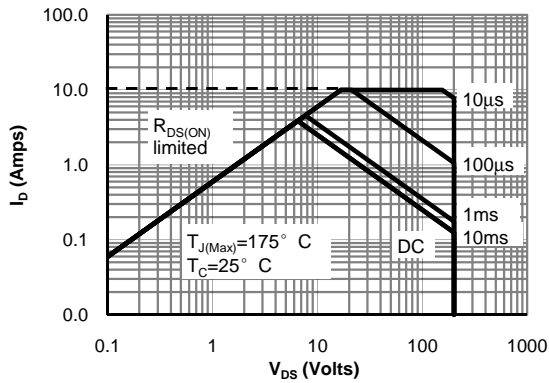


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

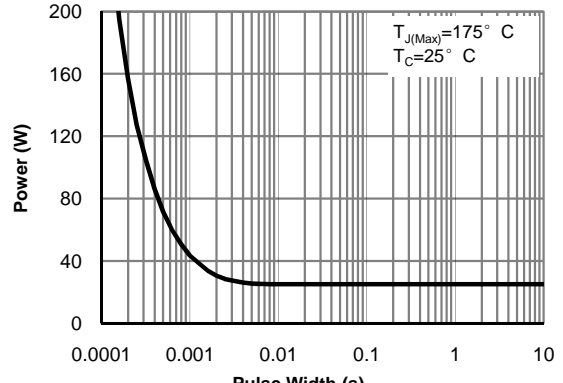


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

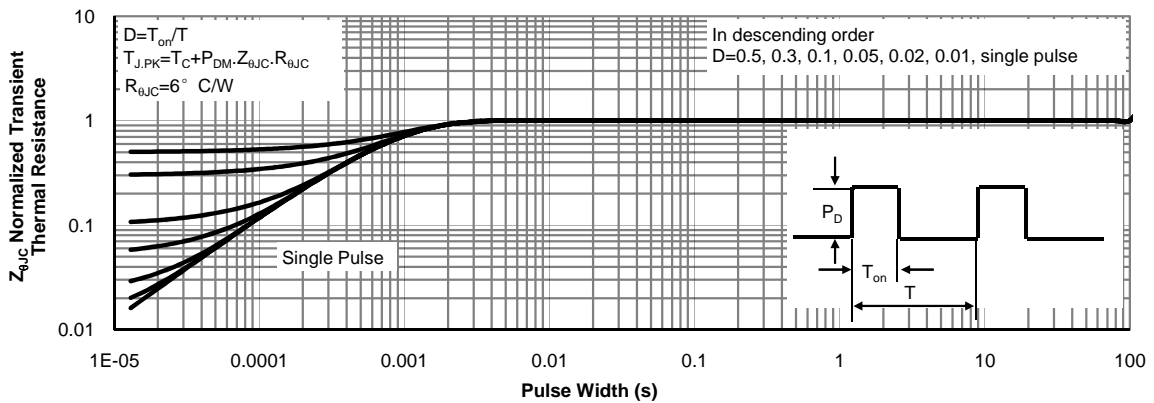
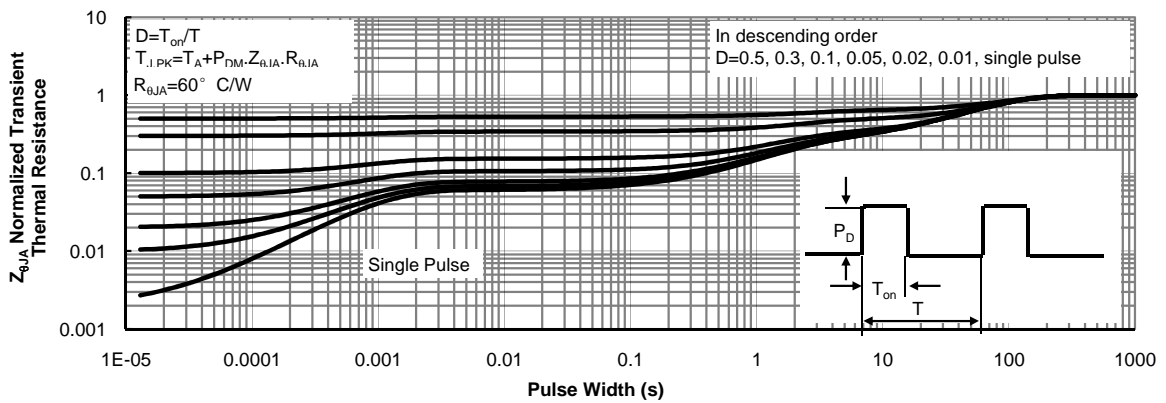
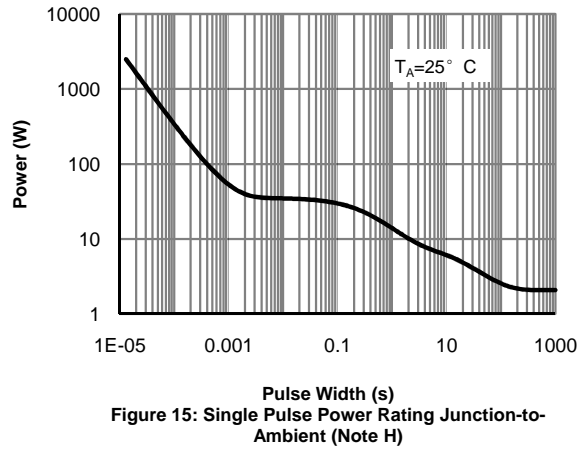
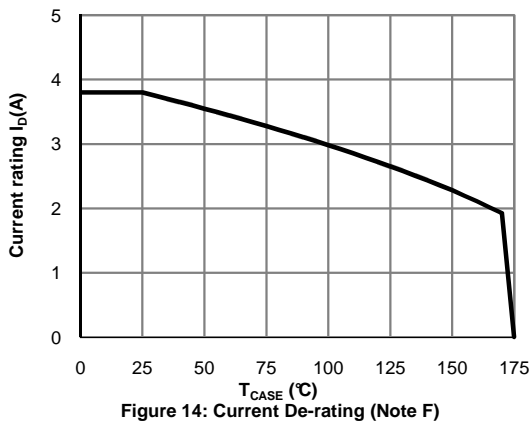
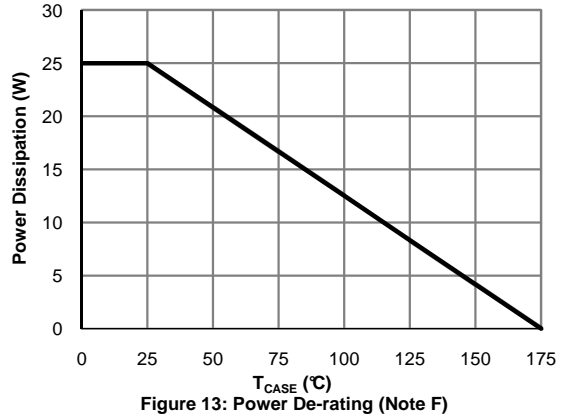
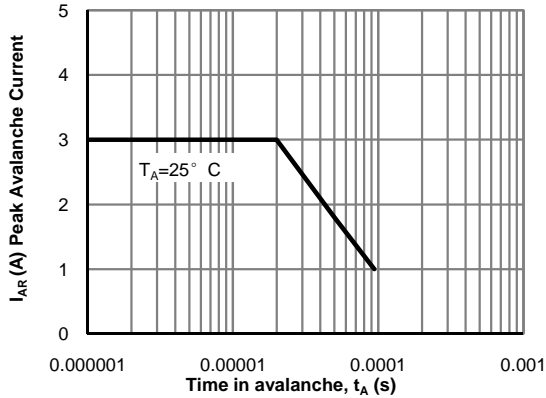
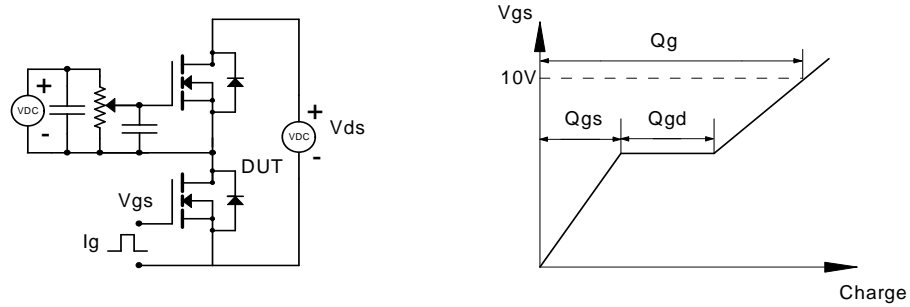


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

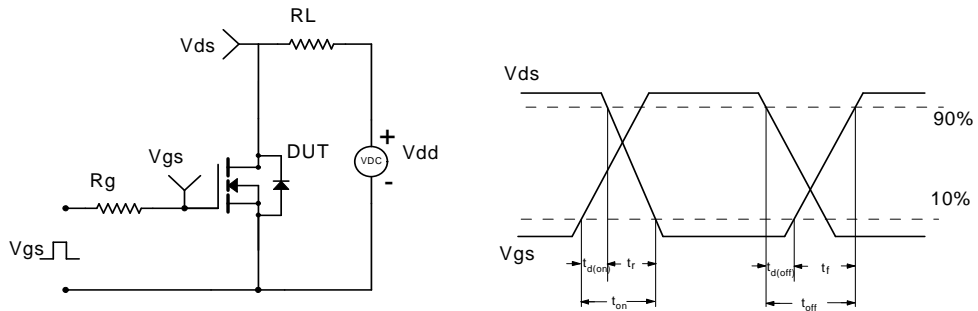
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



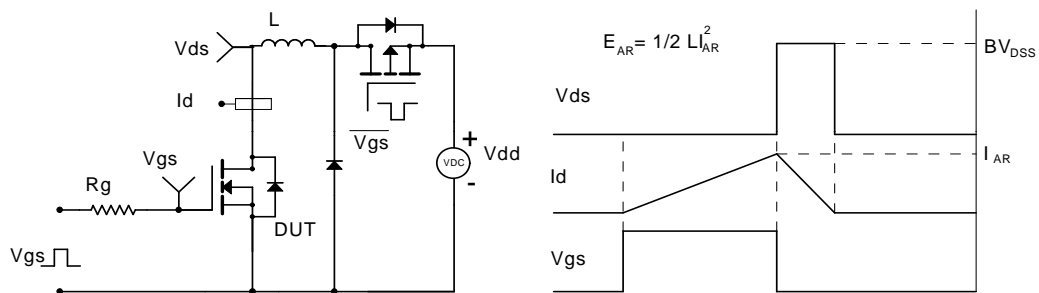
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

